

SMPS MOSFET

IRFB31N20DPbF
IRFS31N20DPbF
IRFSL31N20DPbF

HEXFET® Power MOSFET

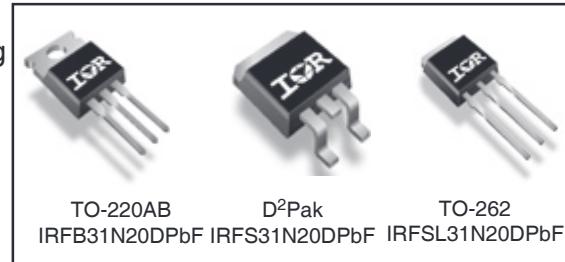
V _{DSS}	R _{DS(on)} max	I _D
200V	0.082Ω	31A

Applications

- High Frequency DC-DC converters
- Lead-Free

Benefits

- Low Gate to Drain to Reduce Switching Losses
- Fully Characterized Capacitance Including Effective COSS to Simplify Design,(See AN 1001)
- Fully Characterized Avalanche Voltage and Current



Absolute Maximum Ratings

	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V	31	A
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V	21	
I _{DM}	Pulsed Drain Current ①	124	
P _D @ T _A = 25°C	Power Dissipation ②	3.1	W
P _D @ T _C = 25°C	Power Dissipation	200	
	Linear Derating Factor	1.3	W/°C
V _{GS}	Gate-to-Source Voltage	± 30	V
dv/dt	Peak Diode Recovery dv/dt ③	2.1	V/ns
T _J	Operating Junction and	-55 to + 175	°C
T _{STG}	Storage Temperature Range		
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	
	Mounting torque, 6-32 or M3 screw④	10 lbf•in (1.1 N•m)	

Applicable Off Line SMPS Topologies

- Telecom 48V Input DC/DC Active Clamp Reset Forward Converter

Notes ① through ④ are on page 11

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Static @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	200	—	—	V	$V_{\text{GS}} = 0\text{V}$, $I_D = 250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}/\Delta T_J}$	Breakdown Voltage Temp. Coefficient	—	0.25	—	V/ $^\circ\text{C}$	Reference to 25°C , $I_D = 1\text{mA}$
$R_{\text{DS}(\text{on})}$	Static Drain-to-Source On-Resistance	—	—	0.082	Ω	$V_{\text{GS}} = 10\text{V}$, $I_D = 18\text{A}$ ④
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	3.0	—	5.5	V	$V_{\text{DS}} = V_{\text{GS}}$, $I_D = 250\mu\text{A}$
I_{DSS}	Drain-to-Source Leakage Current	—	—	25	μA	$V_{\text{DS}} = 200\text{V}$, $V_{\text{GS}} = 0\text{V}$
		—	—	250		$V_{\text{DS}} = 160\text{V}$, $V_{\text{GS}} = 0\text{V}$, $T_J = 150^\circ\text{C}$
I_{GSS}	Gate-to-Source Forward Leakage	—	—	100	nA	$V_{\text{GS}} = 30\text{V}$
	Gate-to-Source Reverse Leakage	—	—	-100		$V_{\text{GS}} = -30\text{V}$

Dynamic @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
g_{fs}	Forward Transconductance	17	—	—	S	$V_{\text{DS}} = 50\text{V}$, $I_D = 18\text{A}$
Q_g	Total Gate Charge	—	70	107	nC	$I_D = 18\text{A}$
Q_{gs}	Gate-to-Source Charge	—	18	23		$V_{\text{DS}} = 160\text{V}$
Q_{gd}	Gate-to-Drain ("Miller") Charge	—	33	65		$V_{\text{GS}} = 10\text{V}$ ④
$t_{d(\text{on})}$	Turn-On Delay Time	—	16	—	ns	$V_{DD} = 100\text{V}$
t_r	Rise Time	—	38	—		$I_D = 18\text{A}$
$t_{d(\text{off})}$	Turn-Off Delay Time	—	26	—		$R_G = 2.5\Omega$
t_f	Fall Time	—	10	—		$R_D = 5.4\Omega$, ④
C_{iss}	Input Capacitance	—	2370	—	pF	$V_{\text{GS}} = 0\text{V}$
C_{oss}	Output Capacitance	—	390	—		$V_{\text{DS}} = 25\text{V}$
C_{rss}	Reverse Transfer Capacitance	—	78	—		$f = 1.0\text{MHz}$
C_{oss}	Output Capacitance	—	2860	—		$V_{\text{GS}} = 0\text{V}$, $V_{\text{DS}} = 1.0\text{V}$, $f = 1.0\text{MHz}$
C_{oss}	Output Capacitance	—	150	—		$V_{\text{GS}} = 0\text{V}$, $V_{\text{DS}} = 160\text{V}$, $f = 1.0\text{MHz}$
$C_{oss \text{ eff.}}$	Effective Output Capacitance	—	170	—		$V_{\text{GS}} = 0\text{V}$, $V_{\text{DS}} = 0\text{V}$ to 160V ⑤

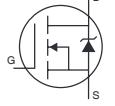
Avalanche Characteristics

	Parameter	Typ.	Max.	Units
E_{AS}	Single Pulse Avalanche Energy ②	—	420	mJ
I_{AR}	Avalanche Current ①	—	18	A
E_{AR}	Repetitive Avalanche Energy ①	—	20	mJ

Thermal Resistance

	Parameter	Typ.	Max.	Units
$R_{\theta\text{JC}}$	Junction-to-Case	—	0.75	$^\circ\text{C/W}$
$R_{\theta\text{CS}}$	Case-to-Sink, Flat, Greased Surface ⑥	0.50	—	
$R_{\theta\text{JA}}$	Junction-to-Ambient ⑥	—	62	
$R_{\theta\text{JA}}$	Junction-to-Ambient ⑦	—	40	

Diode Characteristics

	Parameter	Min.	Typ.	Max.	Units	Conditions
I_S	Continuous Source Current (Body Diode)	—	—	31	A	MOSFET symbol showing the integral reverse p-n junction diode.
I_{SM}	Pulsed Source Current (Body Diode) ①	—	—	124		
V_{SD}	Diode Forward Voltage	—	—	1.3	V	$T_J = 25^\circ\text{C}$, $I_S = 18\text{A}$, $V_{\text{GS}} = 0\text{V}$ ④
t_{rr}	Reverse Recovery Time	—	200	300	ns	$T_J = 25^\circ\text{C}$, $I_F = 18\text{A}$
Q_{rr}	Reverse Recovery Charge	—	1.7	2.6	μC	$dI/dt = 100\text{A}/\mu\text{s}$ ④
t_{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S + L_D$)				

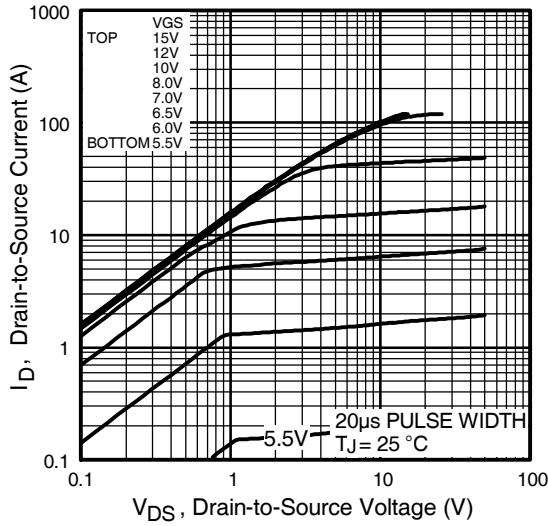


Fig 1. Typical Output Characteristics

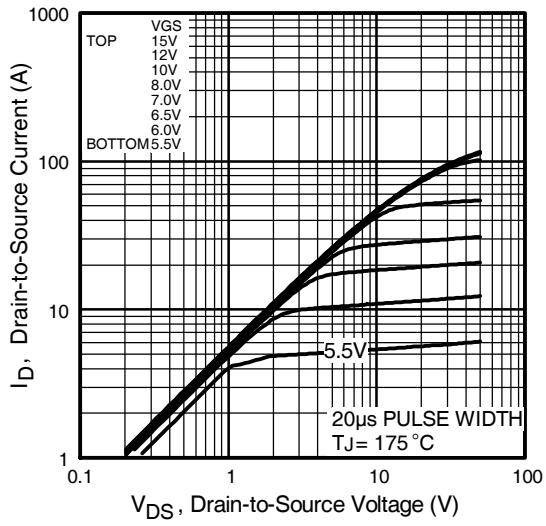


Fig 2. Typical Output Characteristics

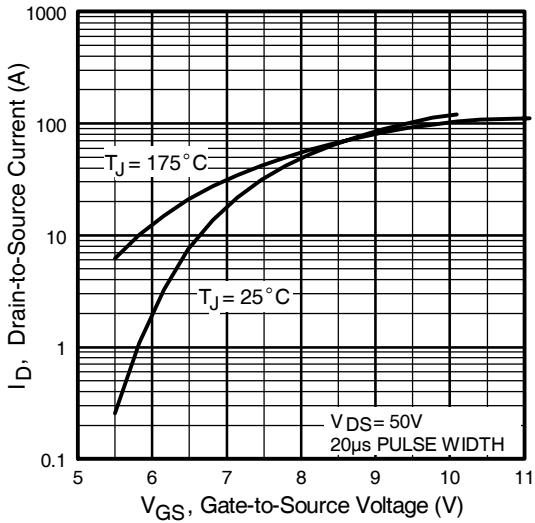


Fig 3. Typical Transfer Characteristics

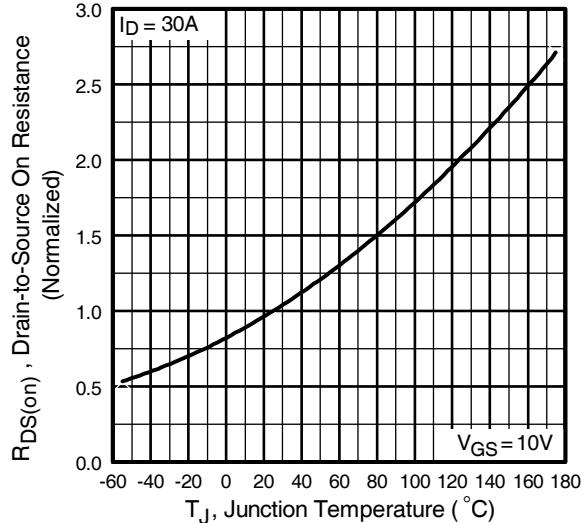


Fig 4. Normalized On-Resistance
Vs. Temperature

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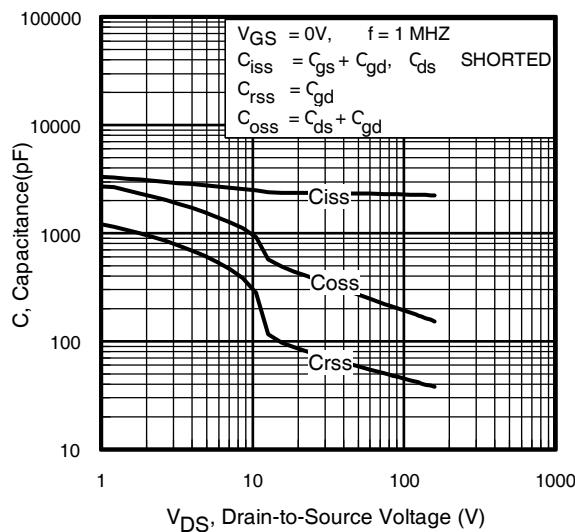


Fig 5. Typical Capacitance Vs.
Drain-to-Source Voltage

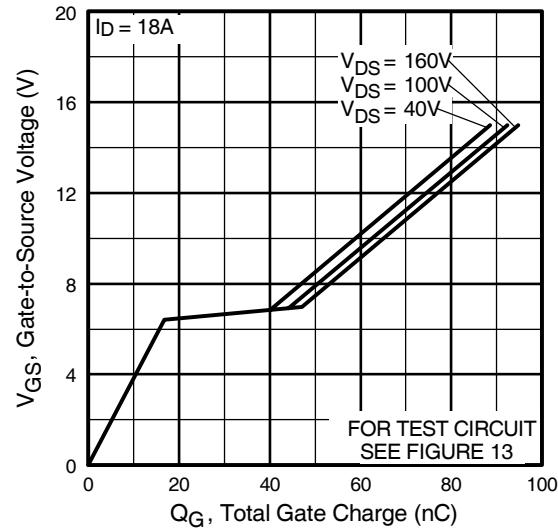


Fig 6. Typical Gate Charge Vs.
Gate-to-Source Voltage

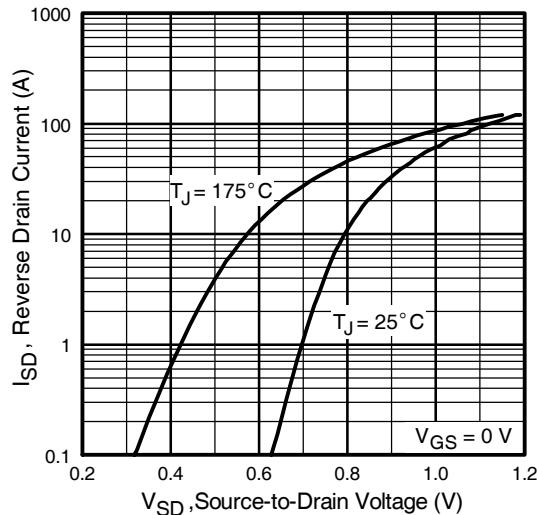


Fig 7. Typical Source-Drain Diode
Forward Voltage

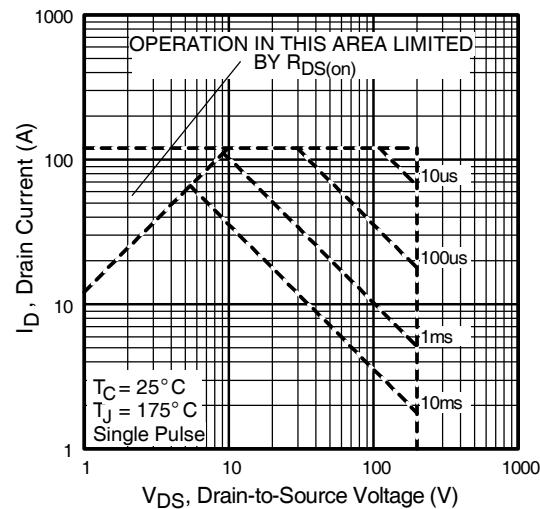


Fig 8. Maximum Safe Operating Area

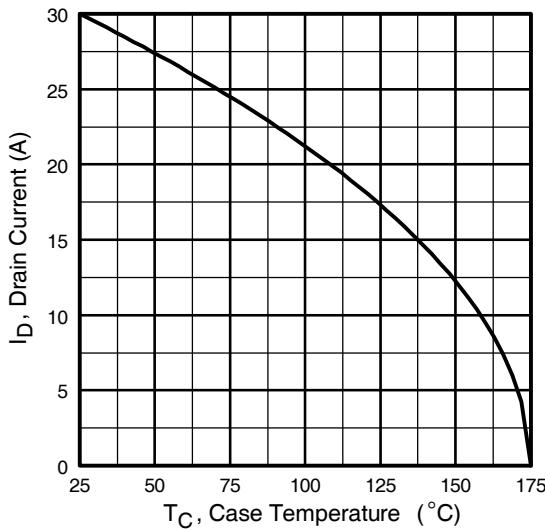


Fig 9. Maximum Drain Current Vs.
Case Temperature

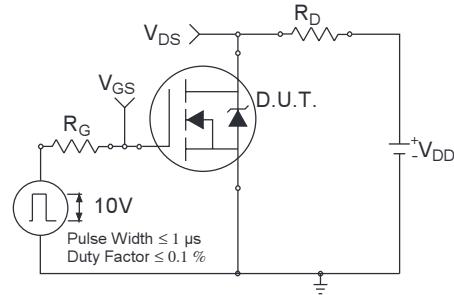


Fig 10a. Switching Time Test Circuit

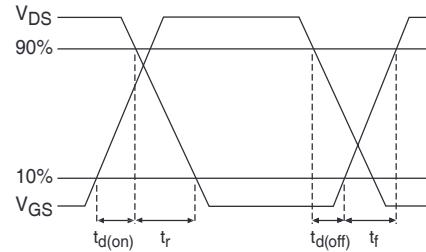


Fig 10b. Switching Time Waveforms

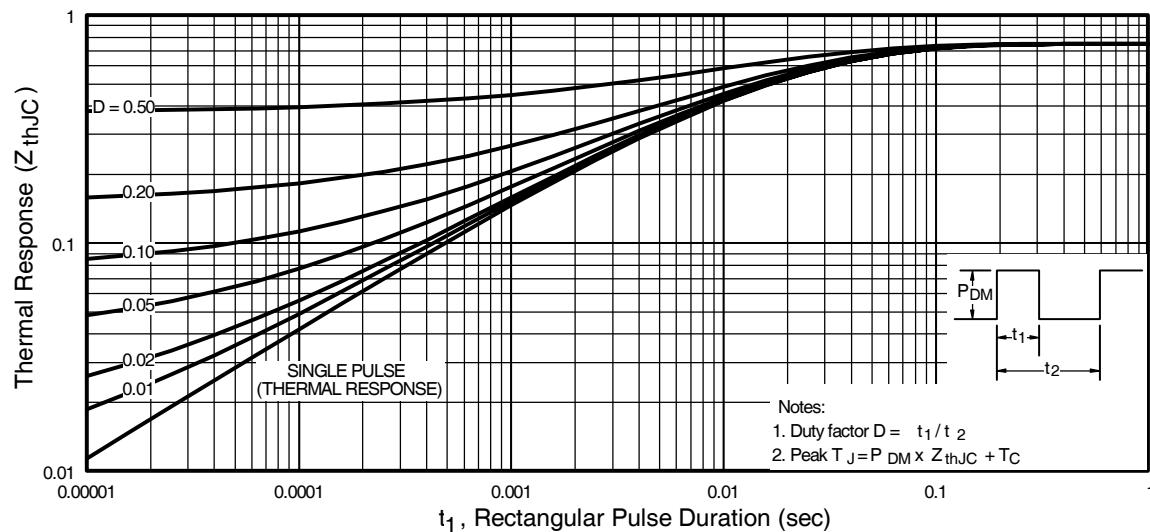


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

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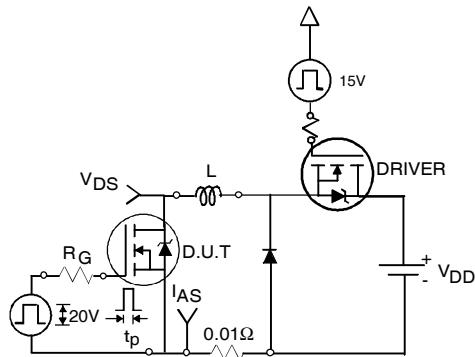


Fig 12a. Unclamped Inductive Test Circuit

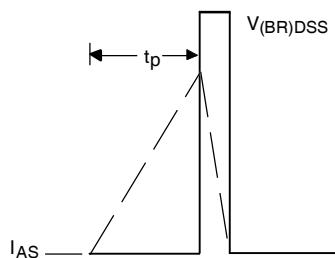


Fig 12b. Unclamped Inductive Waveforms

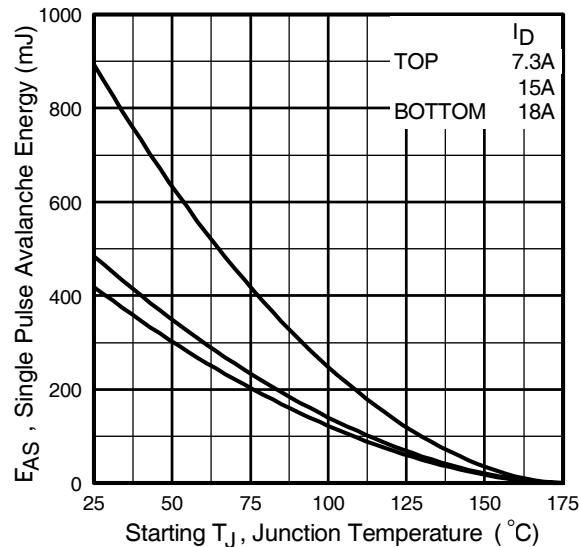


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

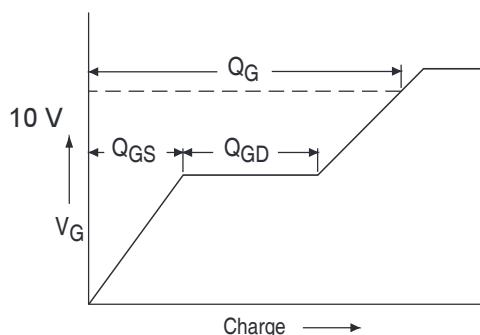


Fig 13a. Basic Gate Charge Waveform

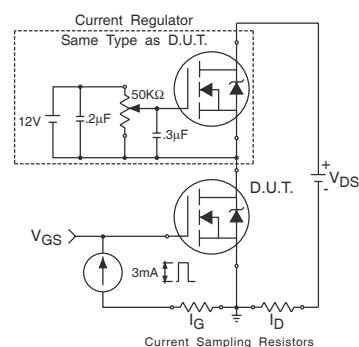
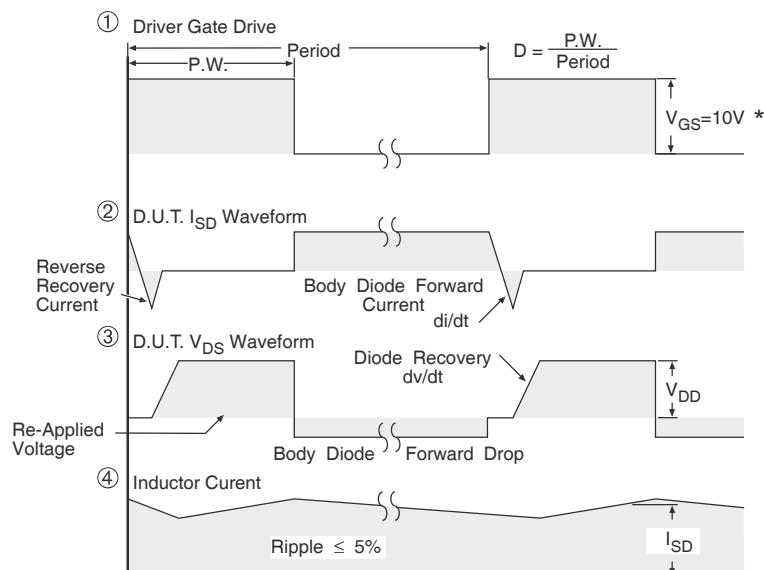
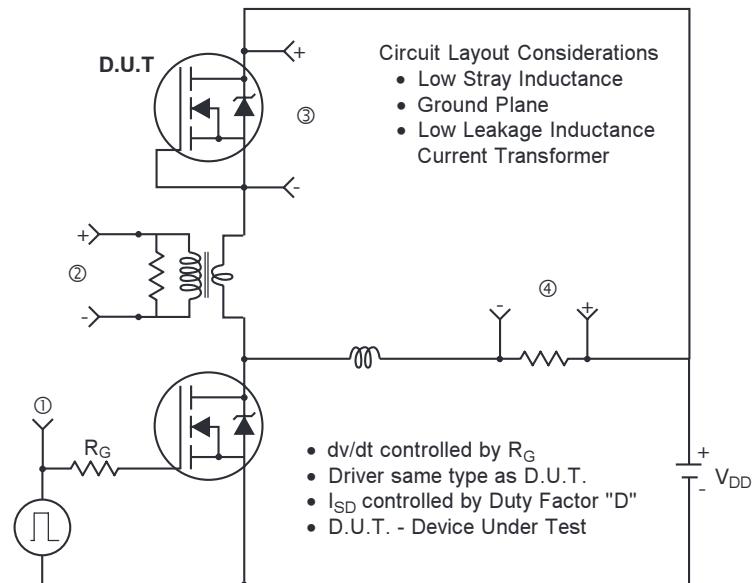


Fig 13b. Gate Charge Test Circuit

Peak Diode Recovery dv/dt Test Circuit

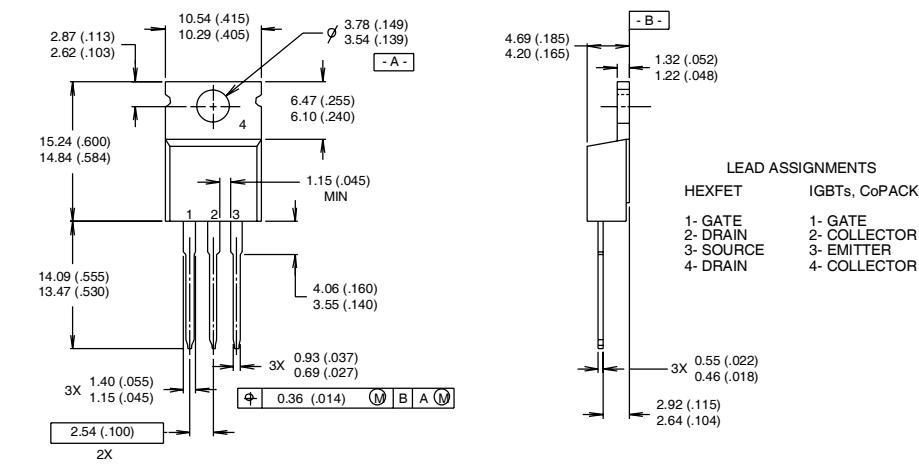


* $V_{GS} = 5V$ for Logic Level Devices

Fig 14. For N-Channel HEXFET® Power MOSFETs

TO-220AB Package Outline

Dimensions are shown in millimeters (inches)



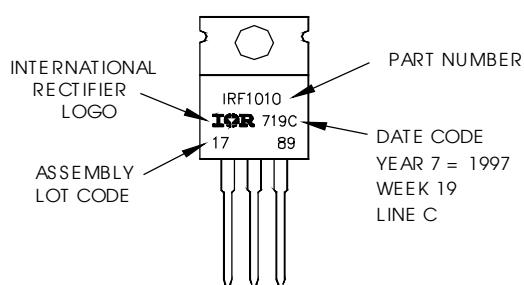
NOTES:

- 1 DIMENSIONING & TOLERANCING PER ANSI Y14.5M, 1982.
- 2 CONTROLLING DIMENSION : INCH

- 3 OUTLINE CONFORMS TO JEDEC OUTLINE TO-220AB.
- 4 HEATSINK & LEAD MEASUREMENTS DO NOT INCLUDE BURRS.

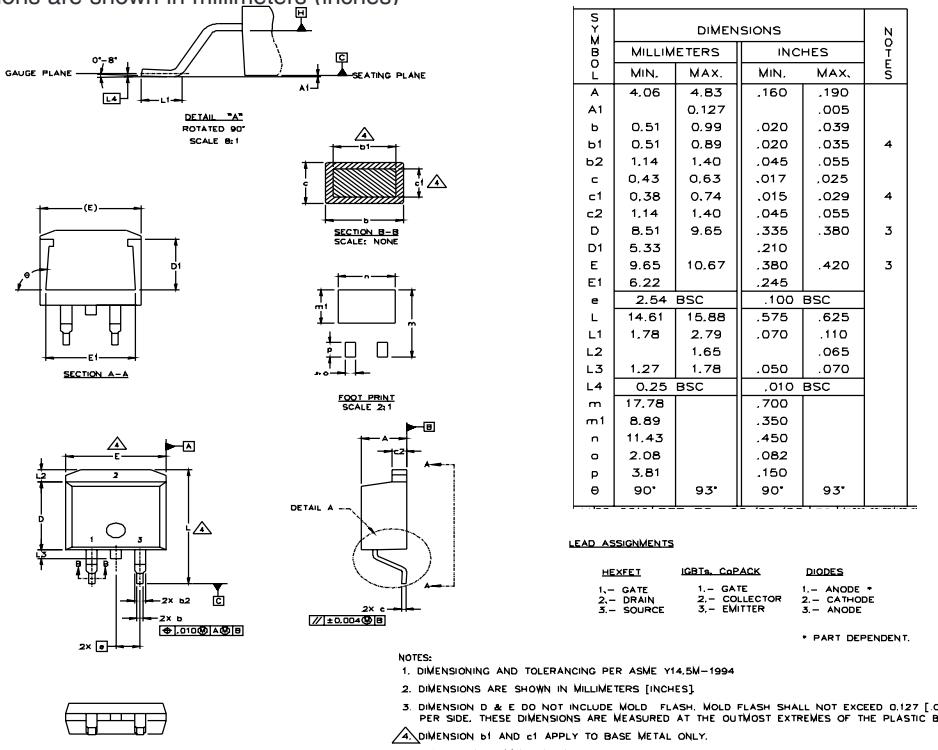
TO-220AB Part Marking Information

EXAMPLE: THIS IS AN IRF1010
 LOT CODE 1789
 ASSEMBLED ON WW 19, 1997
 IN THE ASSEMBLY LINE "C"
Note: "P" in assembly line position indicates "Lead-Free"



D²Pak Package Outline

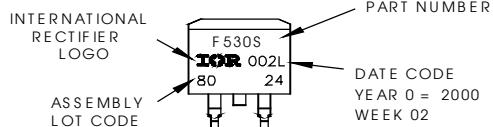
Dimensions are shown in millimeters (inches)



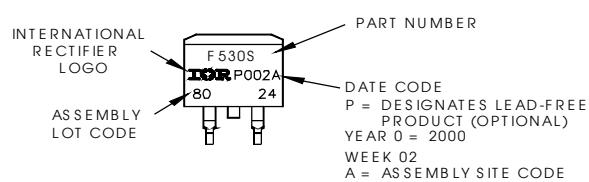
D²Pak Part Marking Information (Lead-Free)

EXAMPLE: THIS IS AN IRF530S WITH
LOT CODE 8024
ASSEMBLED ON WW 02, 2000
IN THE ASSEMBLY LINE "L"

Note: "P" in assembly line
position indicates "Lead-Free"



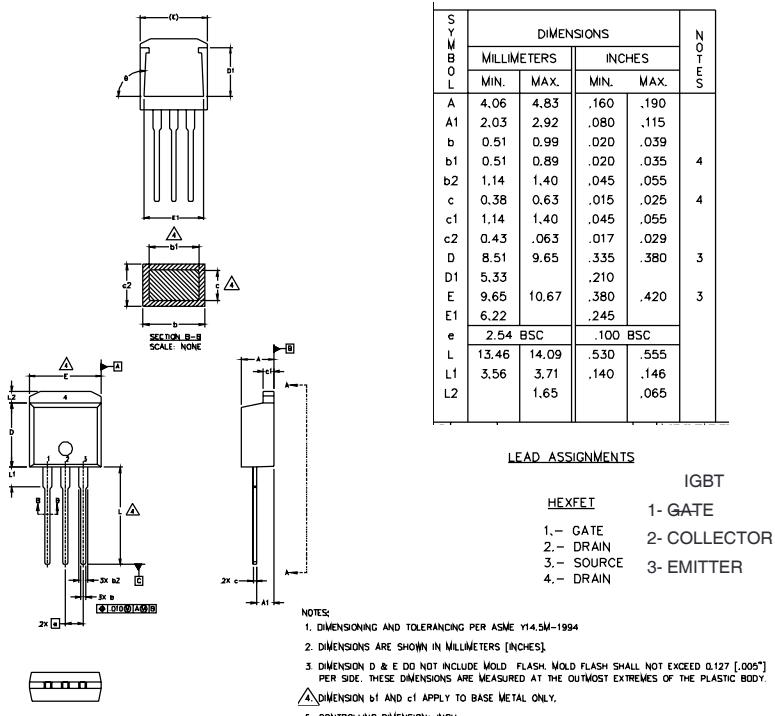
OR



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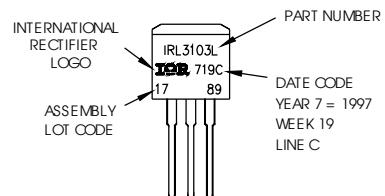
TO-262 Package Outline



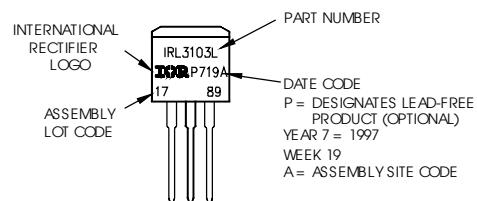
TO-262 Part Marking Information

EXAMPLE: THIS IS AN IRL3103L
LOT CODE 1789
ASSEMBLED ON WW 19, 1997
IN THE ASSEMBLY LINE "C"

Note: "P" in assembly line position indicates "Lead-Free"



OR

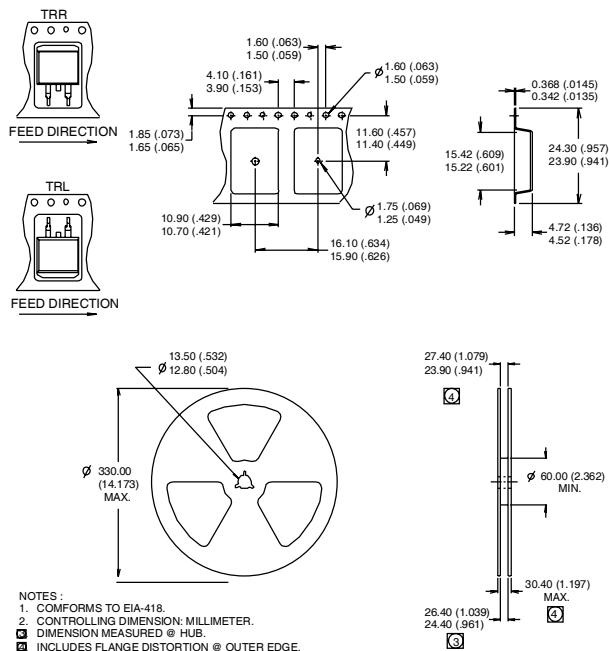


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D²Pak Tape & Reel Infomation

Dimensions are shown in millimeters (inches)



Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ④ Pulse width $\leq 300\mu\text{s}$; duty cycle $\leq 2\%$.
- ② Starting $T_J = 25^\circ\text{C}$, $L = 3.8\text{mH}$
 $R_G = 25\Omega$, $I_{AS} = 18\text{A}$.
- ⑤ C_{oss} eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}
- ③ $I_{SD} \leq 18\text{A}$, $di/dt \leq 110\text{A}/\mu\text{s}$, $V_{DD} \leq V_{(BR)DSS}$, $T_J \leq 175^\circ\text{C}$
- ⑥ This is only applied to TO-220AB package
- ⑦ This is applied to D²Pak, when mounted on 1" square PCB (FR-4 or G-10 Material).
For recommended footprint and soldering techniques refer to application note #AN-994.

Data and specifications subject to change without notice.

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TAC Fax: (310) 252-7903

Visit us at www.irf.com for sales contact information.03/04

Note: For the most current drawings please refer to the IR website at:
<http://www.irf.com/package/>

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